Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/678,998	GOKTURK ET AL.	
Examiner	**Art Unit**	
Patrick J. Lee	2878	

SEARCHED			
Class	Subclass	Date	Examiner
250	221, 222.1, 559.19, 559.4	1/20/2006	PL
250	559.08	1/20/2006	PL
356	606-608	1/20/2006	PL
382	286	1/20/2006	PL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	3/22/2005	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	3/23/2005	PL
Consulted w/ S. Allen AU 2878 CL 250	3/29/2005	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	3/29/2005	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	8/24/2005	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	9/14/2005	PL
East (see attached) - USPAT, US-PGPUB, EPO, JPO, DERWENT	1/20/2006	**PL**